

N-Channel Enhancement Mode MOSFET

TDM3580

DESCRIPTION

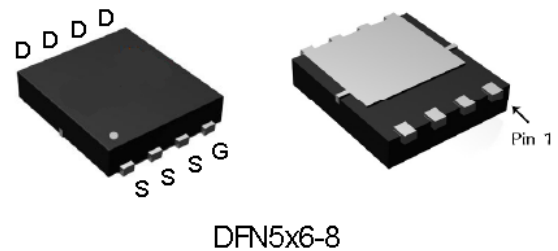
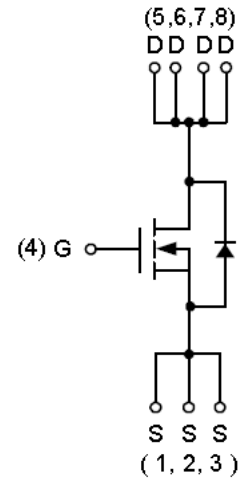
The TDM3580 uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge. This device is suitable for use as a load switch or in PWM applications.

GENERAL FEATURES

- $R_{DS(ON)} < 1.4m\Omega$ @ $V_{GS}=10V$
 $R_{DS(ON)} < 2.1m\Omega$ @ $V_{GS}=4.5V$
- High Power and current handling capability
- Lead free product is available
- Surface Mount Package

Application

- PWM applications
- Load switch
- Power management

ABSOLUTE MAXIMUM RATINGS($T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	40	V
Gate-Source Voltage	V_{GS}	± 20	V
Diode Continuous Forward Current	I_S ($T_C=25^\circ\text{C}$)	47	A
Drain Current @ Continuous(Note 1)	I_D ($T_C=25^\circ\text{C}$)	100	A
	I_D ($T_C=100^\circ\text{C}$)	100	A
Drain Current @ Current-Pulsed (Note 2)	I_{DM} ($T_C=25^\circ\text{C}$)	400	A
Maximum Power Dissipation	P_D ($T_C=25^\circ\text{C}$)	104	W
	P_D ($T_C=100^\circ\text{C}$)	52.1	W
Drain Current @ Continuous	I_D ($T_A=25^\circ\text{C}$)	25.3	A
	I_D ($T_A=70^\circ\text{C}$)	21.2	A
Drain Current @ Current-Pulsed (Note 2)	I_{DM} ($T_A=25^\circ\text{C}$)	101	A
Maximum Power Dissipation	$P_D(T_A=25^\circ\text{C})$	2.5	W
	$P_D(T_A=70^\circ\text{C})$	1.75	W
Avalanche Current, Single pulse(Note 4)	I_{AS} ($L=0.1\text{mH}$)	65	A
Avalanche Energy, Single pulse(Note 4)	$E_{AS}(L=0.1\text{mH})$	211	mJ

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THERMAL CHARACTERISTICS

Maximum Operating Junction Temperature	T _J	175	°C
Storage Temperature Range	T _{STG}	-55 To 175	°C
Thermal Resistance,Junction-to-Case	R _{θJC}	1.44	°C/W
Thermal Resistance,Junction-to-Ambient (Note 3)	R _{θJA}	50	°C/W

ELECTRICAL CHARACTERISTICS (T_A=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	40	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =32V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250μA	1.3	1.7	2.5	V
Drain-Source On-State Resistance(Note5)	R _{DS(ON)}	V _{GS} =10V, I _D =25A	-	1.17	1.4	mΩ
		V _{GS} =4.5V, I _D =15A	-	1.6	2.1	mΩ
Forward Transconductance	G _{fs}	V _{DS} =5V,I _{DS} =15A	-	60	-	S
Diode Characteristics						
Diode Forward Voltage (Note 5)	V _{SD}	V _{GS} =0V,I _{SD} =25A	-	0.75	1.1	V
Reverse Recovery Time	t _{rr}	I _{SD} =25A,dI _{SD} /dt=100A/μs	-	51	-	ns
Charge Time	t _a		-	27	-	
Discharge Time	t _b		-	25	-	
Reverse Recovery Charge	Q _{rr}		-	51	-	nC
Dynamic Characteristics (Note6)						
Gate Resistance	R _G	V _{GS} =0V,V _{DS} =0V,F=1MHz	-	1	2	Ω
Input Capacitance	C _{iss}	V _{DS} =20V,V _{GS} =0V, F=1.0MHz	-	4945	6429	PF
Output Capacitance	C _{oss}		-	1280	-	PF
Reverse Transfer Capacitance	C _{rss}		-	165	-	PF
Turn-on Delay Time	t _{d(on)}	V _{DD} =20V, R _L =20Ω, V _{GEN} =10V,R _G =6Ω I _{DS} =1A	-	21.5	39	nS
Turn-on Rise Time	t _r		-	13	24	nS
Turn-Off Delay Time	t _{d(off)}		-	93	168	nS
Turn-Off Fall Time	t _f		-	87	157	nS
Gate Charge Characteristics(Note6)						
Total Gate Charge	Q _g	V _{DS} =20V,I _D =25A,V _{GS} =10V	-	78	109	nC
Total Gate Charge	Q _g	V _{DS} =20V,I _D =25A,V _{GS} =4.5V	-	36	-	nC
Threshold Gate Charge	Q _{gth}		-	8	-	nC
Gate-Source Charge	Q _{gs}		-	14	-	nC
Gate-Drain Charge	Q _{gd}		-	9.6	-	nC

NOTES:

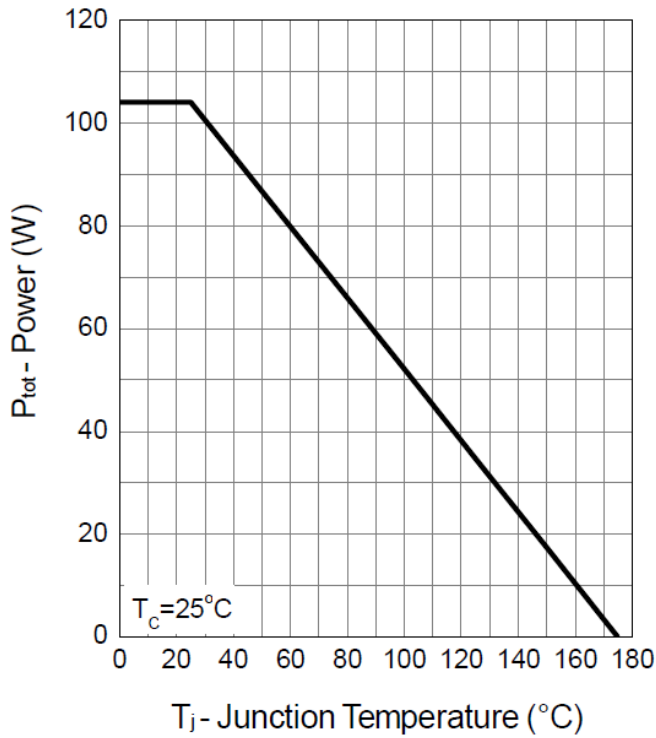
1. Max. continuous current is limited by bonding wire.

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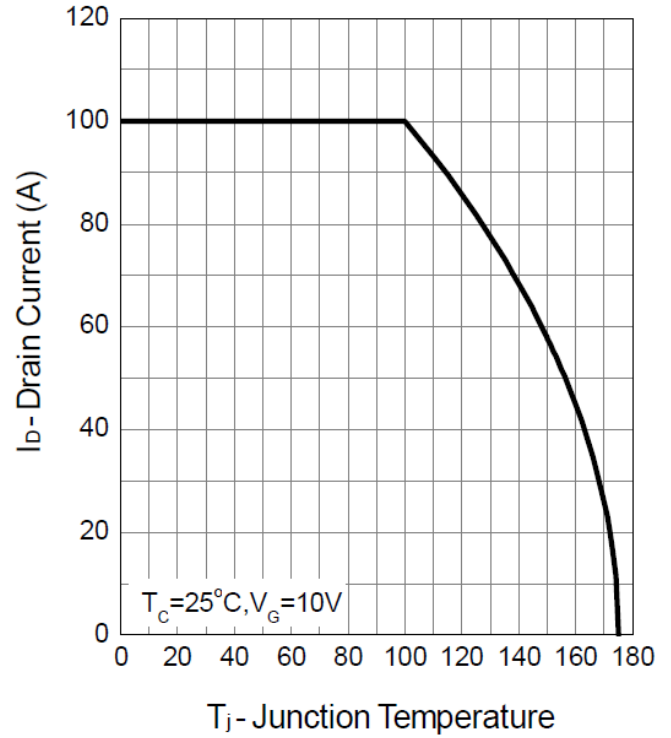
2. Pulse width limited by max. junction temperature.
3. Surface mounted on 1in2 pad area, steady state $t = 999s$.
4. UIS tested and pulse width limited by maximum junction temperature $150^{\circ}C$ (initial temperature $T_j=25^{\circ}C$)..
5. Pulse test ; pulse width $\leq 300ms$, duty cycle $\leq 2\%$.
6. Guaranteed by design, not subject to production testing

Typical Operating Characteristics

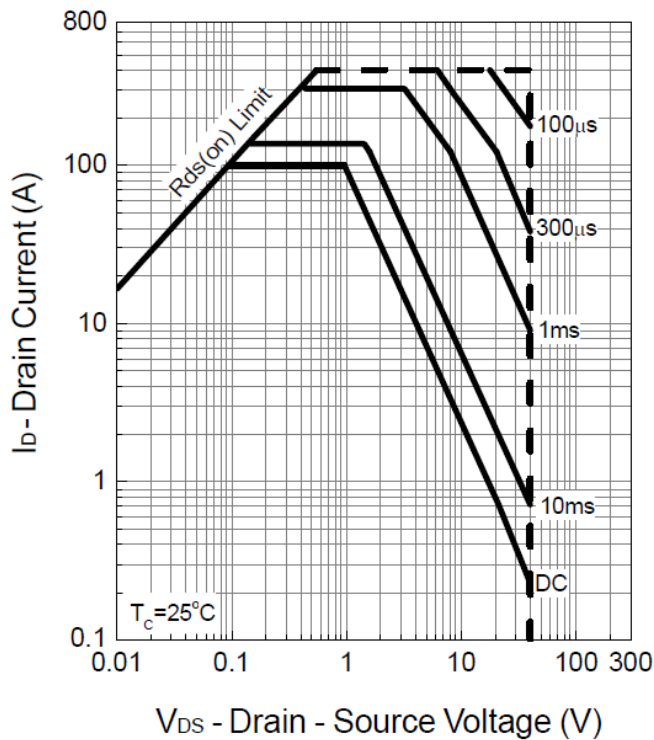
Power Dissipation



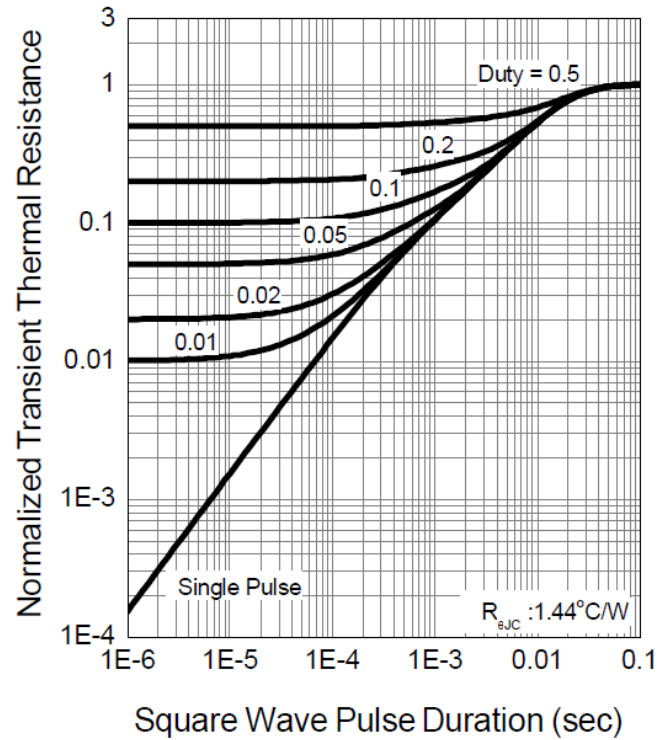
Drain Current



Safe Operation Area

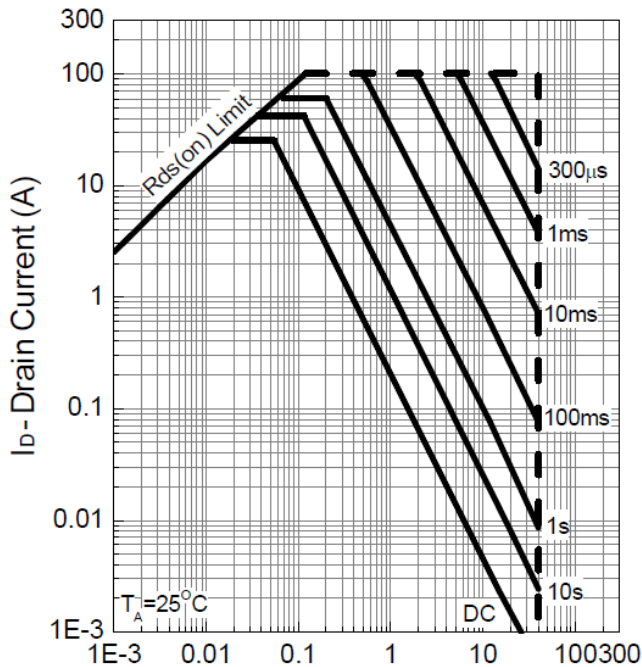


Thermal Transient Impedance



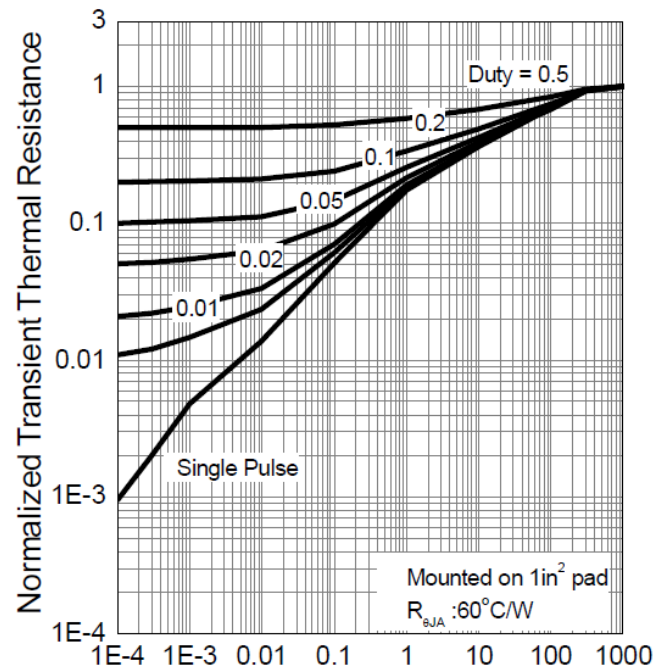
Typical Operating Characteristics(Cont.)

Safe Operation Area



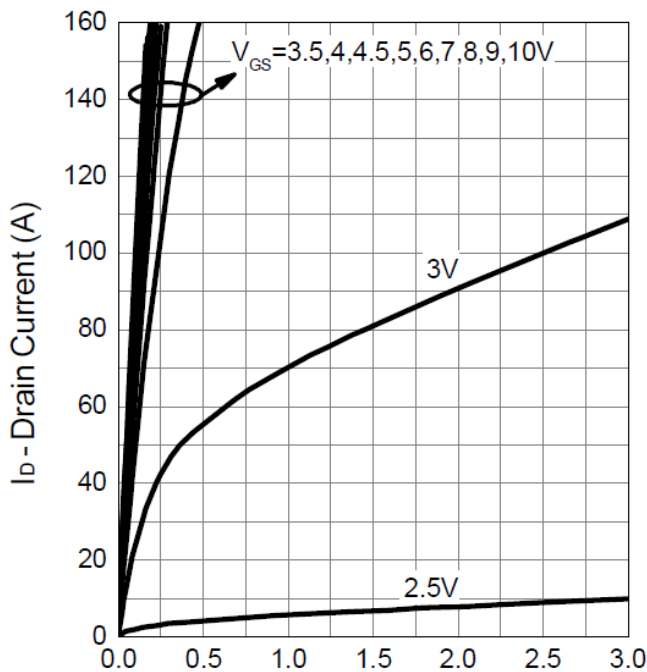
V_{DS} - Drain - Source Voltage (V)

Thermal Transient Impedance



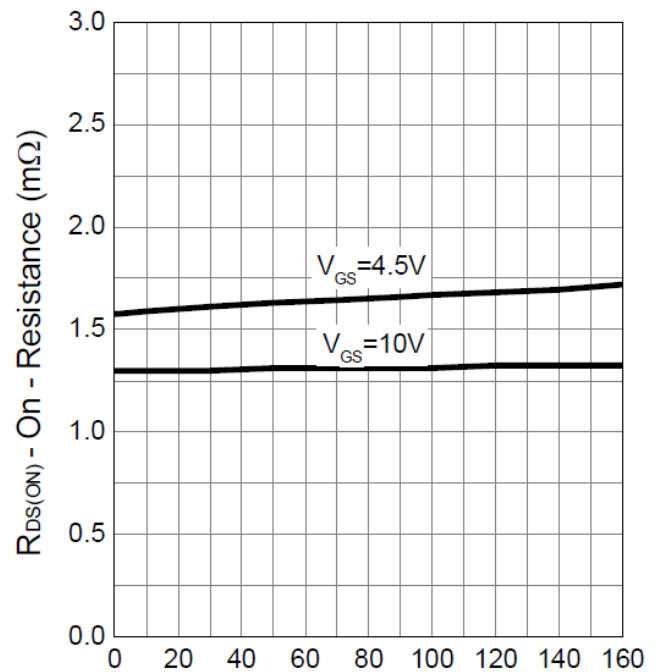
Square Wave Pulse Duration (sec)

Output Characteristics



V_{DS} - Drain - Source Voltage (V)

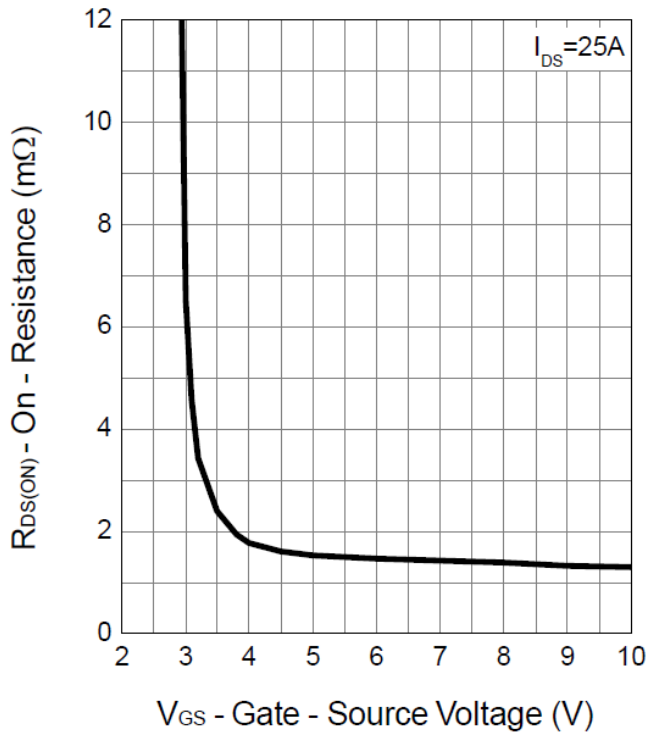
Drain-Source On Resistance



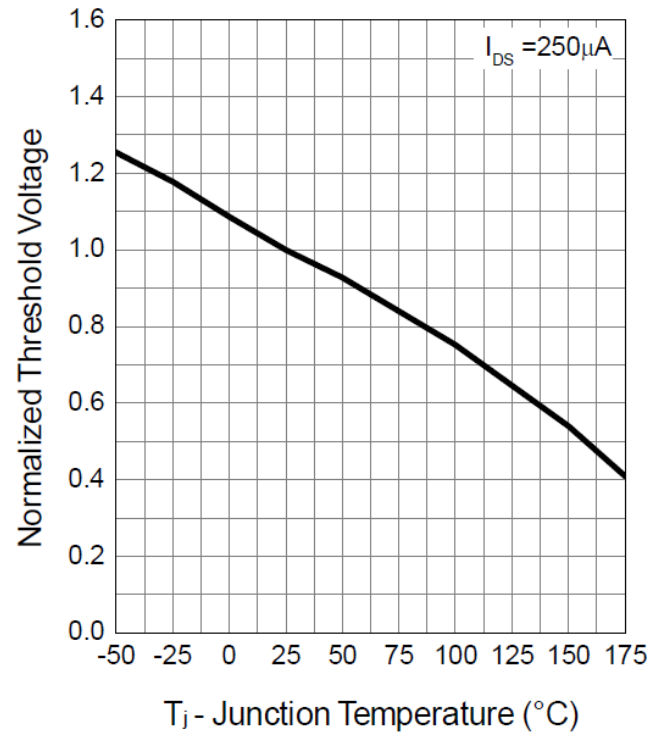
I_D - Drain Current (A)

Typical Operating Characteristics (Cont.)

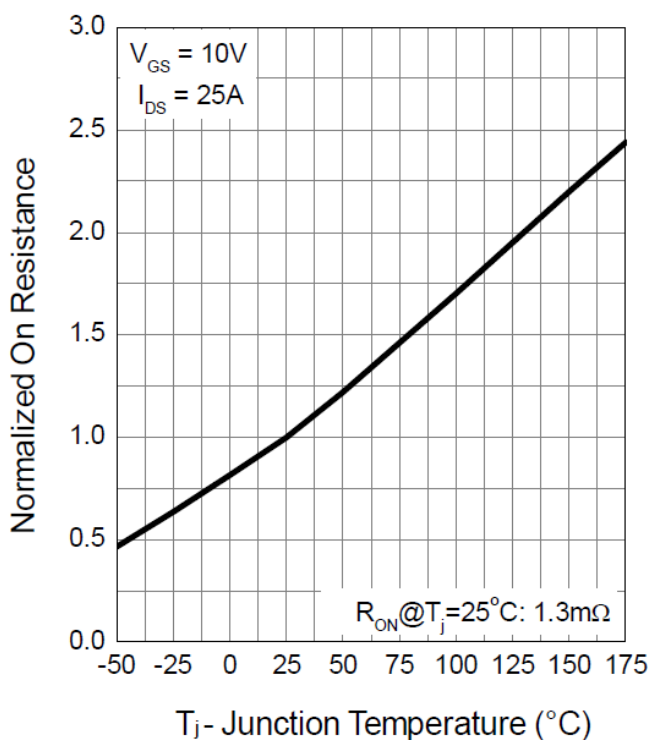
Gate-Source On Resistance



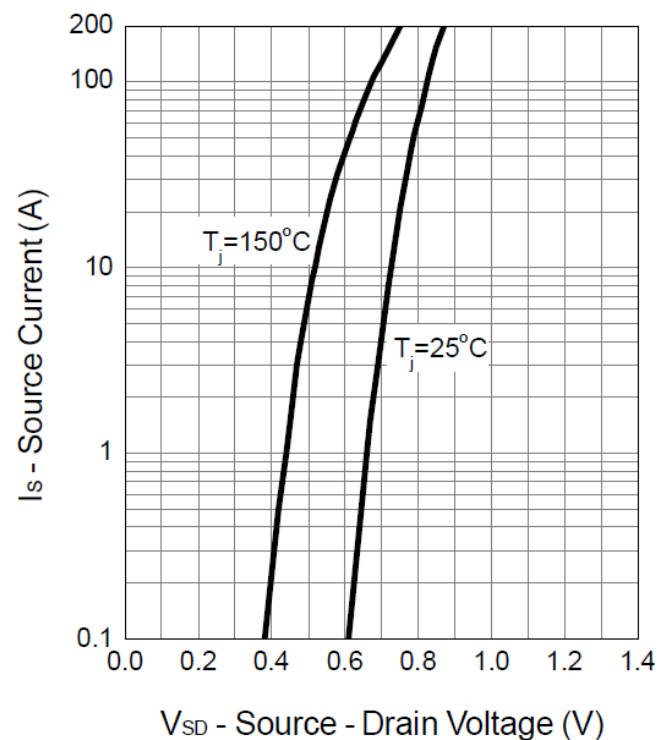
Gate Threshold Voltage



Drain-Source On Resistance

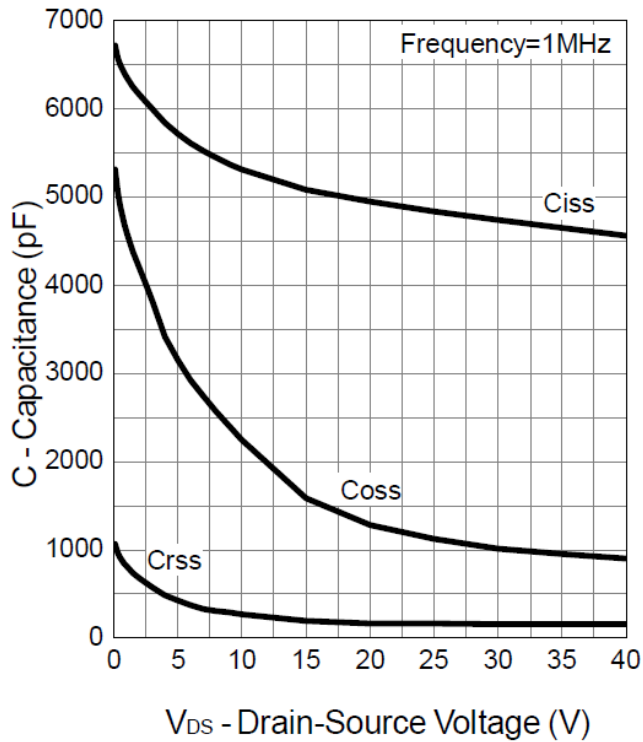


Source-Drain Diode Forward

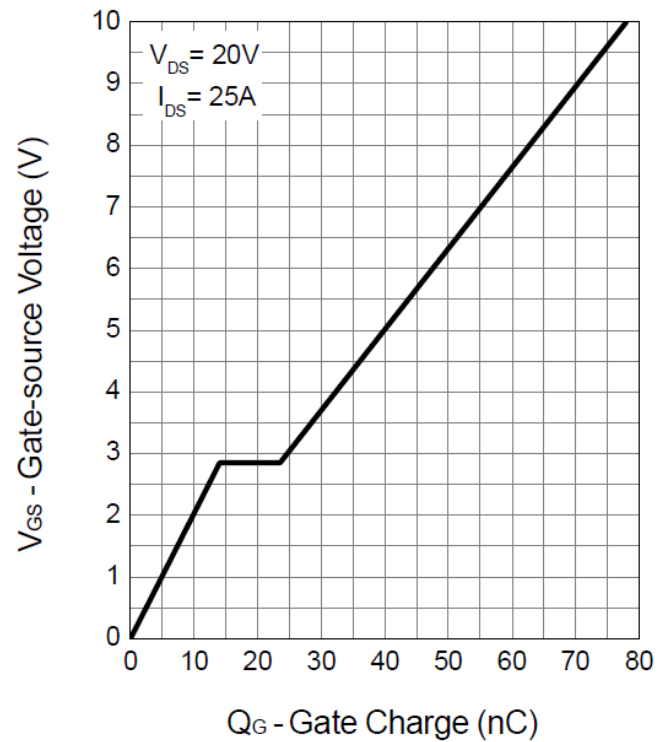


Typical Operating Characteristics (Cont.)

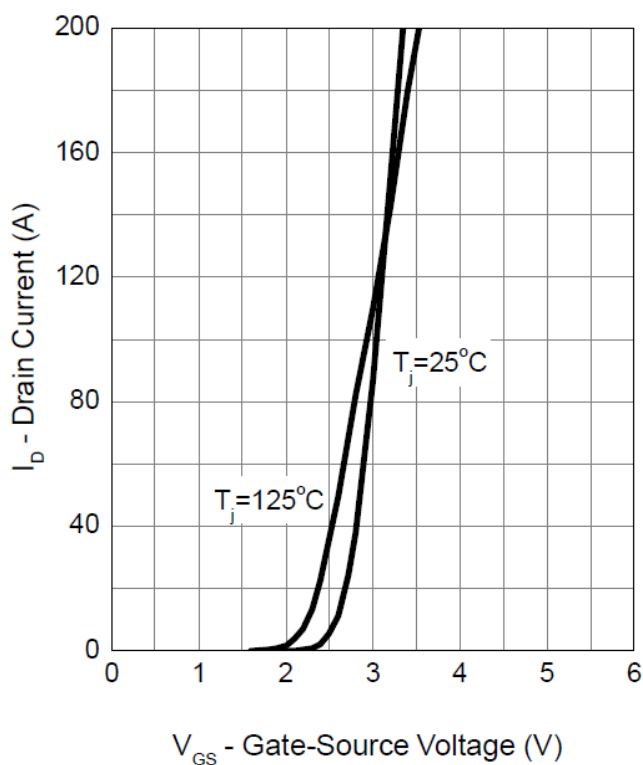
Capacitance



Gate Charge



Transfer Characteristics

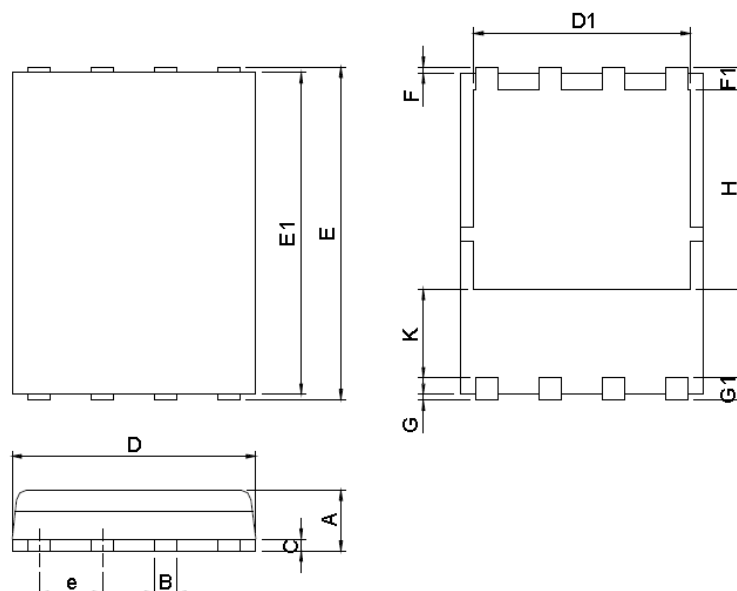


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Package Information

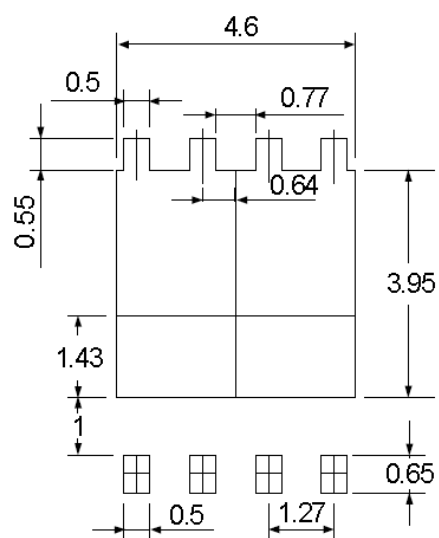
DFN5*6-8 Package



SYMBOL	DFN5x6-8			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	0.90	1.20	0.035	0.047
B	0.3	0.51	0.012	0.020
C	0.19	0.25	0.007	0.010
D	4.80	5.30	0.189	0.209
D1	4.00	4.40	0.157	0.173
E	5.90	6.20	0.232	0.244
E1	5.50	5.80	0.217	0.228
e	1.27 BSC		0.050 BSC	
F	0.05	0.30	0.002	0.012
F1	0.35	0.75	0.014	0.030
G	0.05	0.30	0.002	0.012
G1	0.35	0.75	0.014	0.030
H	3.34	3.9	0.131	0.154
K	0.762	-	0.03	-

Note : 1.Dimension D, D1,D2 and E1 do not include mold flash or protrusions.
Mold flash or protrusions shall not exceed 10 mil.

RECOMMENDED LAND PATTERN



UNIT: mm

Design Notes